

AMENDMENTS TO THE CLAIMS:

This listing of claims will replace all prior versions, and listings, of claims in the application:

1 - 48. (Cancelled)

49. (Currently Amended) An integrated circuit comprising:
a first insulating premetal dielectric layer disposed between a substrate
and a first metal layer;
a trench defined by a recess in the first insulating premetal dielectric layer,
the trench not extending below a top surface of the substrate;
a first contact pillar extending substantially from the top surface of the
substrate to a bottom surface of the first metal layer within the trench; and
a capacitor formed in the trench overlying the first contact pillar such that
the capacitor is formed at least in part on a side of the first contact pillar, and the
first contact pillar is a first plate of the capacitor.
50. (Original) The integrated circuit of claim 49, further comprising a
second contact pillar extending substantially from the top surface of the substrate
to a bottom surface of another portion of the first metal layer, wherein the second
contact pillar is substantially the same height as the first contact pillar.

51. (Original) The integrated circuit of claim 49, wherein the capacitor comprises a storage element of a memory cell.

52. (Original) The integrated circuit of claim 51, wherein a storage node of the storage element comprises the first contact pillar.

53. (Original) The integrated circuit of claim 52, wherein the storage node further comprises a conducting layer lining the trench and the side of the first contact pillar.

54. (Previously Presented) The integrated circuit of claim 50, wherein the second contact pillar is a bit line contact pillar.

55. (Previously Presented) The integrated circuit of claim 49, wherein the capacitor has a capacitor dielectric layer that is comprised of a different material than the premetal dielectric layer.

56. (Previously Presented) The integrated circuit of claim 49, wherein the capacitor has a second plate that is comprised of a different material than the first metal layer.